

AOT280L/AOB280L

80V N-Channel MOSFET

General Description

The AOT280L/AOB280L uses Trench MOSFET technology that is uniquely optimized to provide the most efficient high frequency switching performance. Both conduction and switching power losses are minimized due to an extremely low combination of $R_{\text{DS(ON)}},$ Ciss and Coss. This device is ideal for boost converters and synchronous rectifiers for consumer, telecom, industrial power supplies and LED backlighting.

Product Summary

 V_{DS} 80V I_{D} (at V_{GS} =10V) 140A

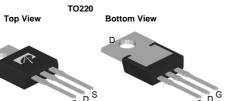
$$\begin{split} R_{DS(ON)} & (\text{at V}_{GS} \text{=} 10\text{V}) \\ R_{DS(ON)} & (\text{at V}_{GS} \text{=} 6\text{V}) \\ \end{split} \qquad \begin{array}{ll} < 2.7 \text{m}\Omega & (< 2.2 \text{m}\Omega^*) \\ < 3.5 \text{m}\Omega & (< 3.1 \text{m}\Omega^*) \\ \end{array}$$

100% UIS Tested 100% R_g Tested

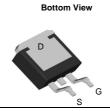
Top View

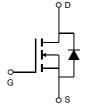


AOT280L



AOB280L TO-263





Absolute Maximum Ratings T _A =25°C unless otherwise noted	
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Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V _{DS}	80	V	
Gate-Source Voltage		V _{GS}	±20	V	
Continuous Drain	T _C =25℃		140		
Current ^G	T _C =100℃	I _D	110	A	
Pulsed Drain Current C		I _{DM}	560		
Continuous Drain	T _A =25℃		20.5	A	
Current	T _A =70℃	IDSM	16		
Avalanche Current ^C		I _{AS}	70	А	
Avalanche energy L=0.3mH ^C		E _{AS}	735	mJ	
	T _C =25℃	В	333	W	
Power Dissipation ^B	T _C =100℃	— P _D —	166.5	VV	
	T _A =25℃	В	2.1	W	
Power Dissipation A	T _A =70℃	P _{DSM}	1.3		
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 175	C	

Thermal Characteristics							
Parameter	Symbol	Тур	Units				
Maximum Junction-to-Ambient A	t ≤ 10s		12	15	°C/W		
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	48	60	€/M		
Maximum Junction-to-Case Steady-Stat		$R_{\theta JC}$	0.35	0.45	C/W		

^{*} Surface mount package TO263



Electrical Characteristics (T_J=25℃ unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC I	PARAMETERS						
BV_{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V					V
1	Zero Gate Voltage Drain Current	V _{DS} =80V, V _{GS} =0V				1	
I _{DSS}	Zero Gate Voltage Drain Current	T _J =55℃				5	μΑ
I_{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} =±20V				±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_{D}=250\mu A$			2.75	3.4	V
$I_{D(ON)}$	On state drain current	V_{GS} =10V, V_{DS} =5V					Α
		V_{GS} =10V, I_D =20A			2.2	2.7	
		TO220	T _J =125℃		3.4	4.2	mΩ
R _{DS(ON)}		V_{GS} =6V, I_D =20A			2.5	3.5	mΩ
	Static Drain-Source On-Resistance	TO220			2.5	3.5	11152
	Static Dialii-Source Off-Resistance	V_{GS} =10V, I_D =20A			1.8	2.2	mΩ
		TO263		1.0	2.2	11132	
		V _{GS} =6V, I _D =20A TO263			2.2	3.1	mΩ
					2.2		11152
g _{FS}	Forward Transconductance	V_{DS} =5V, I_{D} =20A			76		S
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V			0.67	1	V
Is	Maximum Body-Diode Continuous Current ^G					140	Α
DYNAMI	CPARAMETERS						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =40V, f=1MHz			11135		pF
C _{oss}	Output Capacitance				1315		pF
C _{rss}	Reverse Transfer Capacitance				80		pF
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1I	MHz	0.4	0.75	1.2	Ω
SWITCH	NG PARAMETERS						
Q _{g(10V)}	Total Gate Charge	V _{GS} =10V, V _{DS} =40V, I _D =20A			160	224	nC
Q_{gs}	Gate Source Charge				38		nC
Q_{gd}	Gate Drain Charge				28		nC
t _{D(on)}	Turn-On DelayTime	$V_{GS}=10V, V_{DS}=40V, R_{L}=2\Omega,$ $R_{GEN}=3\Omega$			30		ns
t _r	Turn-On Rise Time				23		ns
t _{D(off)}	Turn-Off DelayTime				75		ns
t _f	Turn-Off Fall Time				27		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =20A, dI/dt=500A/μs			44		ns
Q _{rr}	Body Diode Reverse Recovery Charge	e I _F =20A, dI/dt=500A/μs			348		nC

A. The value of $R_{\theta,JA}$ is measured with the device mounted on 1in^2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The Power dissipation P_{DSM} is based on R $_{\theta,JA}$ and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175° C may be used if the PCB allows it.

- D. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient.
- E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.
- F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=175° C. The SOA curve provides a single pulse rating.
- G. The maximum current limited by package.
- H. These tests are performed with the device mounted on 1 in FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^{\circ}$ C.

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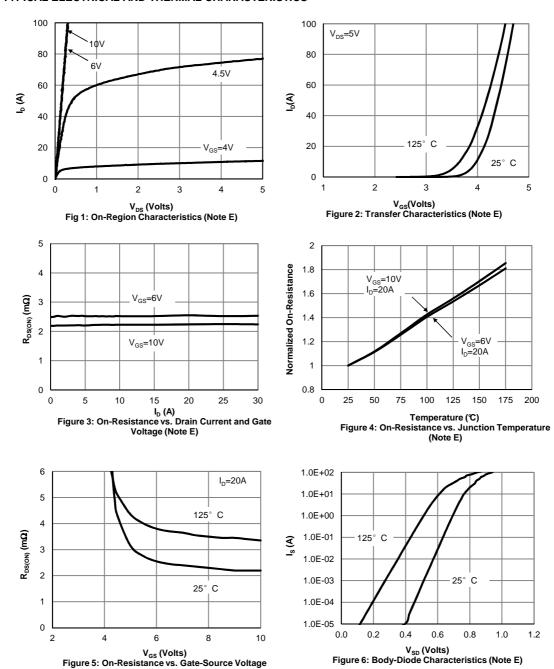
B. The power dissipation P_D is based on $T_{J(MAX)} = 175^\circ$ C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}$ =175° C. Ratings are based on low frequency and duty cycles to keep initial T_J =25° C.



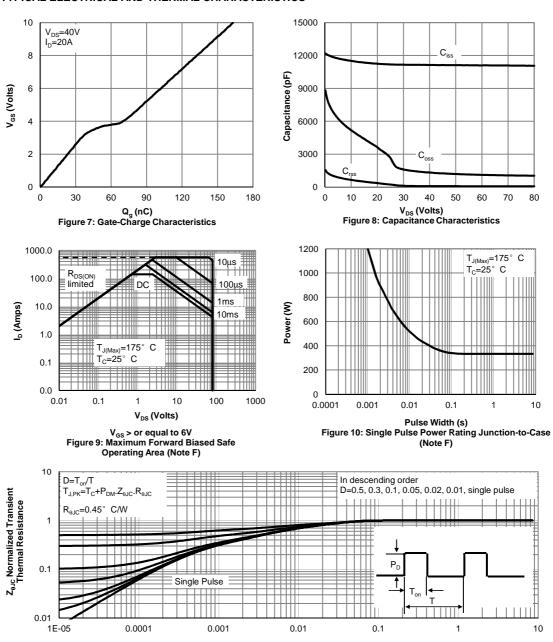
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

(Note E)





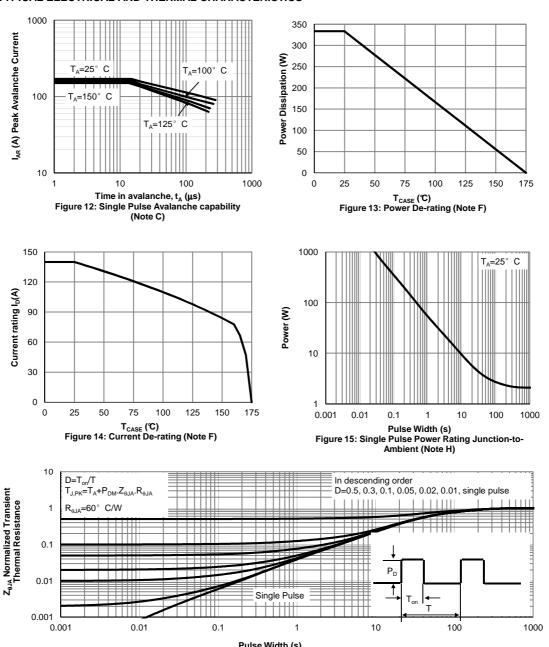
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Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)



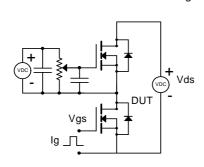
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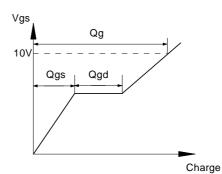


Pulse Width (s)
Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

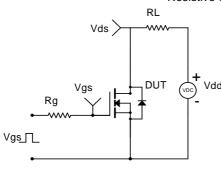


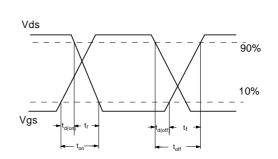
Gate Charge Test Circuit & Waveform



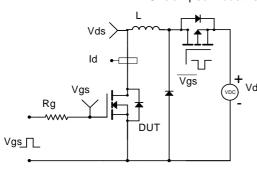


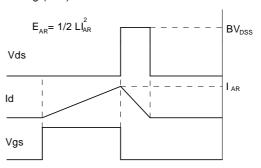
Resistive Switching Test Circuit & Waveforms



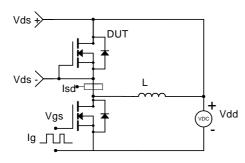


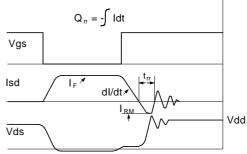
Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





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